

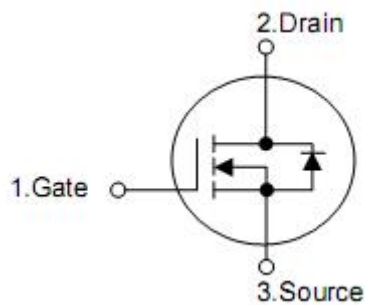
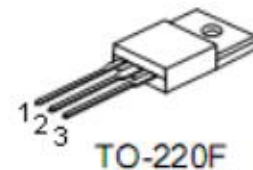
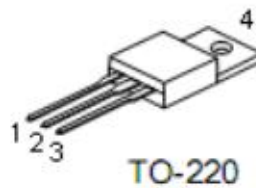
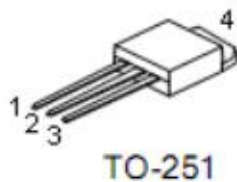
## 1. Description

The KIA730H N-Channel enhancement mode silicon gate power MOSFET is designed for high voltage, high speed power switching applications such as switching regulators, switching converters, solenoid, motor drivers, relay drivers.

## 2. Features

- n  $R_{DS(on)}=0.83\Omega$  (Typ) @  $V_{GS}=10\text{ V}$
- n Low gate charge (typical 20nC)
- n Avalanche energy specified
- n Fast switching capability
- n Improved dv/dt capability

## 3. Pin configuration



Pin	Function
1	Gate
2	Drain
3	Source
4	Drain

#### 4. Absolute maximum ratings

(T<sub>C</sub>=25 °C , unless otherwise specified)

Parameter	Symbol	Ratings			Units	
		T0251	T0220	T0220F		
Drain-source voltage	V <sub>DSS</sub>	400			V	
Gate-source voltage	V <sub>GSS</sub>	±30			V	
Drain current continuous	I <sub>D</sub>	T <sub>C</sub> =25°C	6.0*	6.0	6.0*	A
		T <sub>C</sub> =100°C	3.6*	3.6	3.6*	A
Drain current pulsed ( note1 )	I <sub>DP</sub>	24*	24	24*	A	
Avalanche energy	Repetitive (note1)	E <sub>AR</sub>			7.3	mJ
	Single pulse (note2)	E <sub>AS</sub>			270	mJ
Peak diode recovery dv/dt (note 3)	dv/dt	4.5			V/ns	
Total power dissipation	P <sub>D</sub>	T <sub>C</sub> =25°C	42	73	38	W
		Derate above 25°C	0.35	0.58	0.30	W/°C
Junction temperature	T <sub>J</sub>	+150			°C	
Storage temperature	T <sub>STG</sub>	-55~+150			°C	

\*Drain current limited by maximum junction temperature

#### 5. Thermal characteristics

Parameter	Symbol	Rating			Unit
		T0251	T0220	T0220F	
Thermal resistance,Junction-to-case	R <sub>thJC</sub>	2.11	1.71	3.31	°C/W
Thermal resistance,Junction-to-ambient	R <sub>thJA</sub>	62.5	62.5	62.5	°C/W
Thermal resistance, Case-to-sink typ.	R <sub>thCS</sub>	0.5	0.5	--	°C/W

## 6. Electrical characteristics

(T<sub>J</sub>=25°C, unless otherwise notes)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
<b>Off Characteristics</b>						
Drain-source breakdown voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	400	-	-	V
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> =400V, V <sub>GS</sub> =0V	-	-	1	μA
		V <sub>DS</sub> =320V, T <sub>C</sub> =125 °C	-	-	10	μA
Gate-body leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =30V, V <sub>DS</sub> =0V	-	-	100	nA
		V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V	-	-	-100	nA
Breakdown voltage temperature	ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	I <sub>D</sub> =250μA,	-	0.54	-	V/°C
<b>On characteristics</b>						
Gate threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	2.0	-	4.0	V
Static drain-source on-resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =3.0A	-	0.83	1.0	Ω
<b>Dynamic characteristics</b>						
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1MHz	-	520	-	pF
Output capacitance	C <sub>oss</sub>		-	80	-	pF
Reverse transfer capacitance	C <sub>rss</sub>		-	15	-	pF
<b>Switching characteristics</b>						
Turn-on delay time	t <sub>d(on)</sub>	V <sub>DD</sub> =200V, I <sub>D</sub> =6.0A, R <sub>G</sub> =25Ω (note4,5)	-	10	-	ns
Rise time	t <sub>r</sub>		-	60	-	ns
Turn-off delay time	t <sub>d(off)</sub>		-	20	-	ns
Fall time	t <sub>f</sub>		-	40	-	ns
Total gate charge	Q <sub>g</sub>	V <sub>DS</sub> =320V, I <sub>D</sub> =6.0A, V <sub>GS</sub> =10V (note4,5)	-	18	-	nC
Gate-source charge	Q <sub>gs</sub>		-	2.5	-	nC
Gate-drain charge	Q <sub>gd</sub>		-	8.5	-	nC
<b>Drain-source diode characteristics</b>						
Drain-source diode forward voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>SD</sub> =6.0A	-	-	1.4	V
Continuous Drain-source current	I <sub>SD</sub>		-	-	6.0	A
Pulsed Drain-source current	I <sub>SM</sub>		-	-	24.0	A
Reverse recovery time	t <sub>rr</sub>	I <sub>SD</sub> =6.0A,	-	250	-	ns
Reverse recovery charge	Q <sub>rr</sub>	dI <sub>SD</sub> /dt=100A/μs (note 4)	-	2.0	-	μC

Note: 1.Repetitive Rating:Pulse width limited by maximum junction temperature

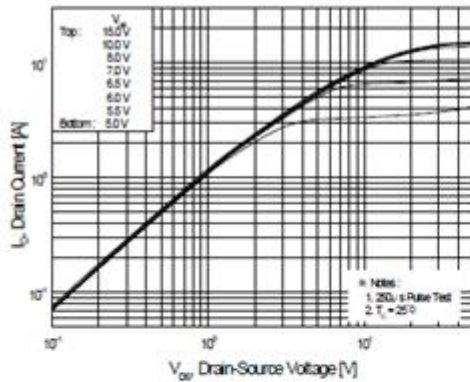
2.L=14mH, I<sub>AS</sub>=6.0A, V<sub>DD</sub>=50V, R<sub>G</sub>=25Ω, Starting T<sub>J</sub>=25 °C

3.I<sub>SD</sub>≤6.0A, di/dt≤200A/μs, V<sub>DD</sub>≤ BV<sub>DSS</sub>, Starting T<sub>J</sub>=25 °C

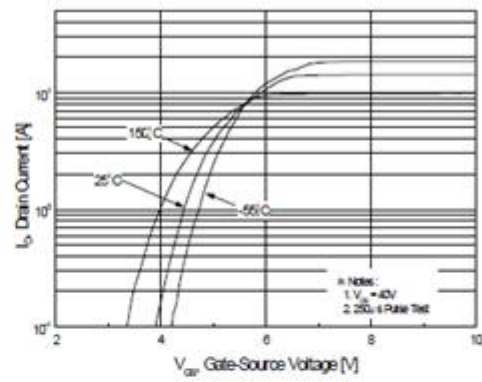
4.Pulse test:pulse width≤300μs,duty cycle≤2%

5.Essentially independent of operating temperature

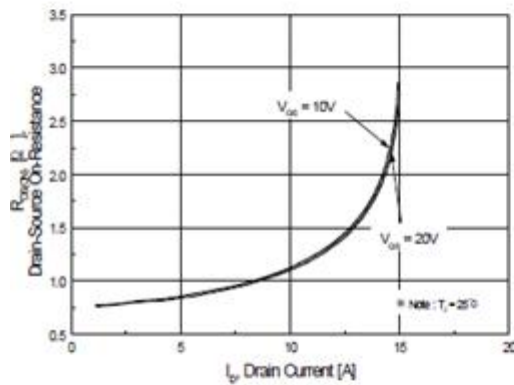
**7. Test circuits and waveforms**



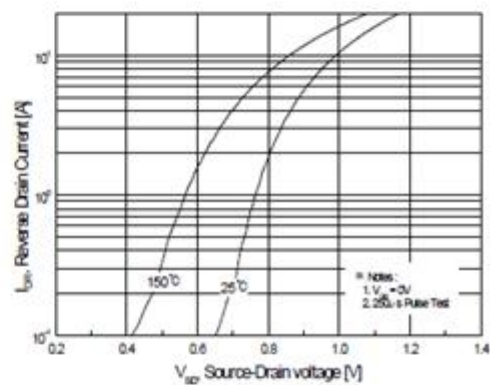
**Figure 1. On-Region Characteristics**



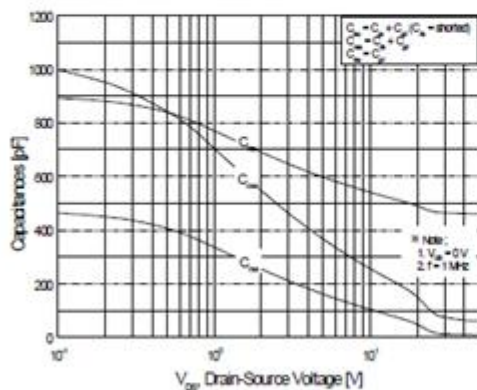
**Figure 2. Transfer Characteristics**



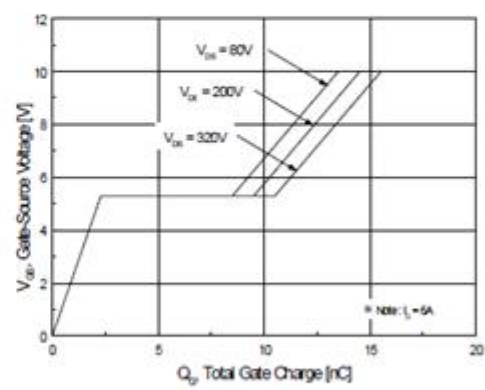
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



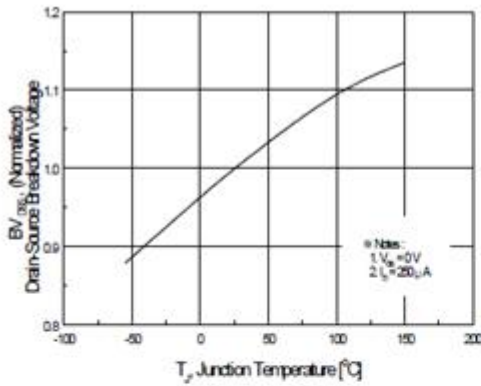
**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**



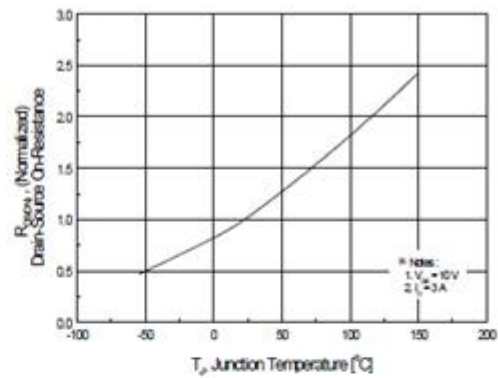
**Figure 5. Capacitance Characteristics**



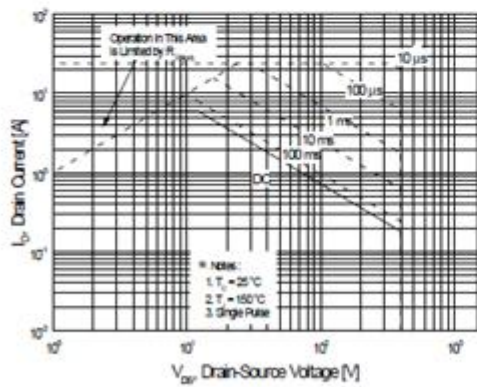
**Figure 6. Gate Charge Characteristics**



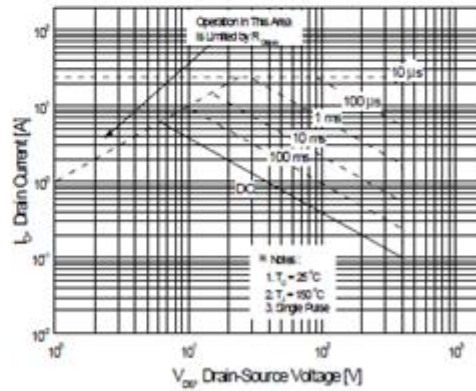
**Figure 7. Breakdown Voltage Variation vs Temperature**



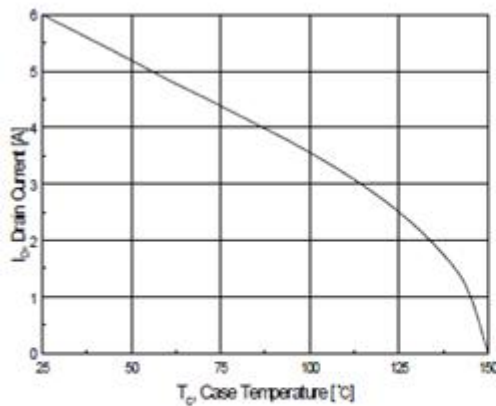
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9-1. Maximum Safe Operating Area for T0220**

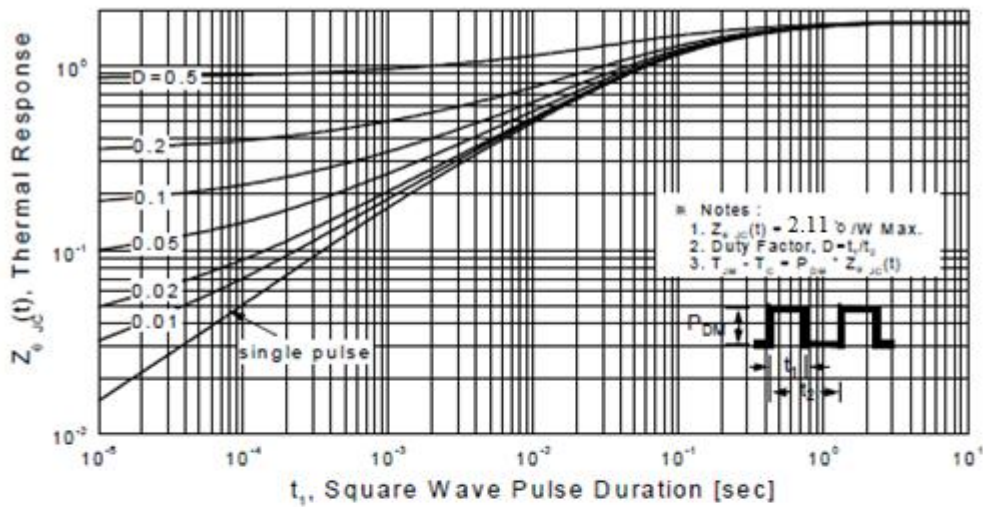


**Figure 9-2. Maximum Safe Operating Area for T0220F or TO-251**

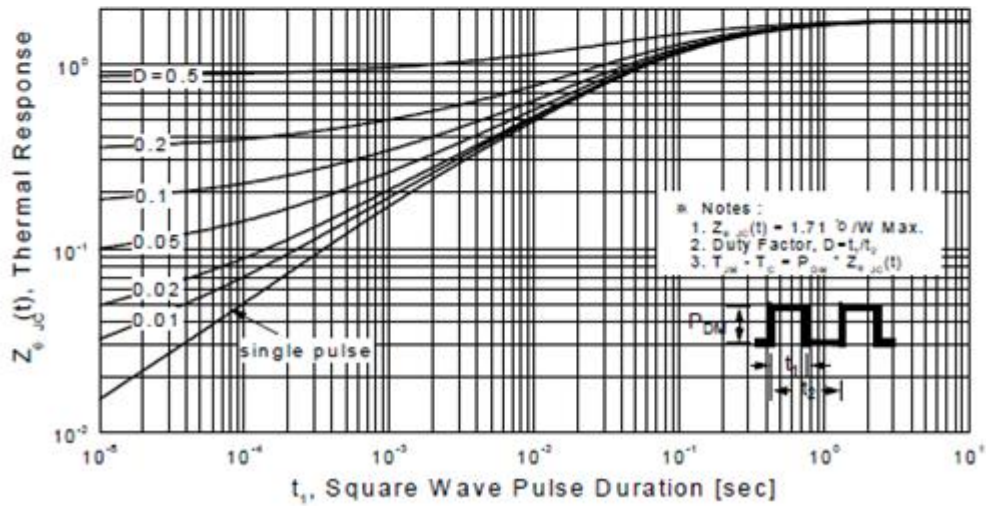


**Figure 10. Maximum Drain Current vs Case Temperature**

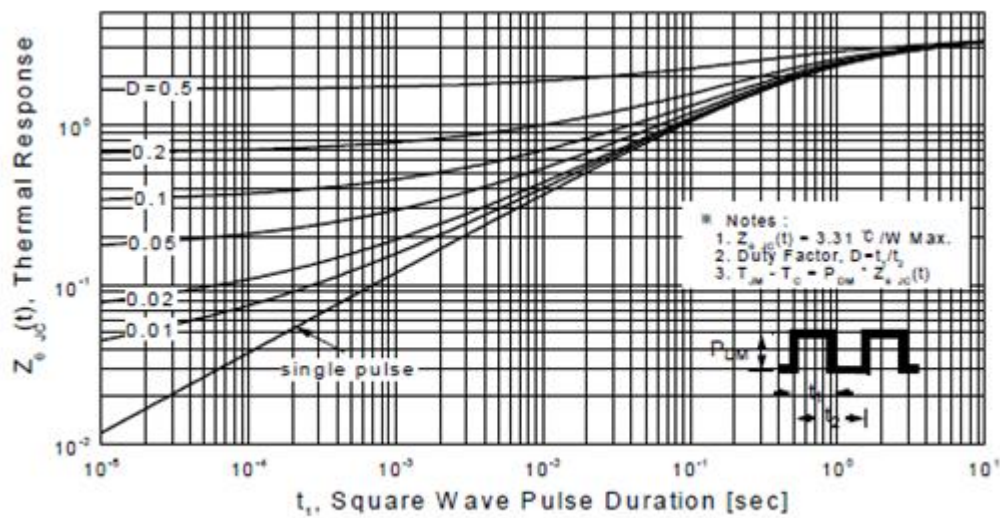




**Figure 11-1. Transient Thermal Response Curve for TO-251**



**Figure 11-2. Transient Thermal Response Curve for TO220**



**Figure 11-3. Transient Thermal Response Curve for TO220F**